

**Search Notes**

Application/Control No.

10/065,174

Examiner

Frank Duong

Applicant(s)/Patent under  
Reexamination

TSENG ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search (see printout)	4/28/2006	FD
IEEE/Internet Search	4/28/2006	FD
Inventorship Search (see printout)	4/27/2006	FD